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SERIAL NUMBER 10/749,670	FILING or 371(c) DATE 12/30/2003 RULE	CLASS 356	GROUP ART UNIT 2624	ATTORNEY DOCKET NO. 2522-047
APPLICANTS Deok-Yong Kim, Gyeonggi-do, KOREA, REPUBLIC OF; Byoung-Ho Lee, Gyeonggi-do, KOREA, REPUBLIC OF; DR				
** CONTINUING DATA ***** DR				
** FOREIGN APPLICATIONS ***** REPUBLIC OF KOREA 2003-102 01/02/2003				
** IF REQUIRED, FOREIGN FILING LICENSE GRANTED ** 04/29/2004				
Foreign Priority claimed <input checked="" type="checkbox"/> Yes <input type="checkbox"/> No 35 USC 119(a-d) conditions met <input checked="" type="checkbox"/> Yes <input type="checkbox"/> No Verified and /MICHAEL A Acknowledged NEWMAN/ Examiner's Signature	<input type="checkbox"/> Met after Allowance Initials	STATE OR COUNTRY KOREA, REPUBLIC OF	SHEETS DRAWINGS 10	TOTAL CLAIMS 27
INDEPENDENT CLAIMS 3				
ADDRESS MARGER JOHNSON & MCCOLLOM, P.C. 210 SW MORRISON STREET, SUITE 400 PORTLAND, OR 97204 UNITED STATES				
TITLE Method and apparatus for detecting defects on a wafer				
FILING FEE RECEIVED 896	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:		<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees (Filing) <input type="checkbox"/> 1.17 Fees (Processing Ext. of time) <input type="checkbox"/> 1.18 Fees (Issue) <input type="checkbox"/> Other _____ <input type="checkbox"/> Credit	